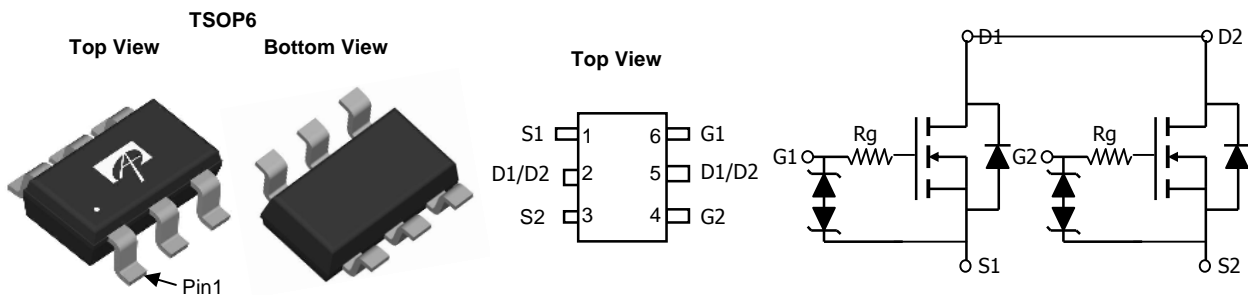


### General Description

The AO6804A uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch applications.

### Product Summary

$V_{DS} = 20V$   
 $I_D = 5.0A$  ( $V_{GS} = 4.5V$ )  
 $R_{DS(ON)} < 28m\Omega$  ( $V_{GS} = 4.5V$ )  
 $R_{DS(ON)} < 30m\Omega$  ( $V_{GS} = 4.0V$ )  
 $R_{DS(ON)} < 34m\Omega$  ( $V_{GS} = 3.1V$ )  
 $R_{DS(ON)} < 39m\Omega$  ( $V_{GS} = 2.5V$ )



### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	$V_{DS}$	20	V
Gate-Source Voltage	$V_{GS}$	$\pm 12$	V
Continuous Drain Current <sup>A</sup>	$I_D$	$T_A=25^\circ C$	5
		$T_A=70^\circ C$	4
Pulsed Drain Current <sup>B</sup>	$I_{DM}$	25	A
Power Dissipation <sup>A</sup>	$P_D$	$T_A=25^\circ C$	1.3
		$T_A=70^\circ C$	0.8
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	$^\circ C$

### Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient <sup>A</sup>	$R_{\theta JA}$	76	95	$^\circ C/W$
Maximum Junction-to-Ambient <sup>A</sup>		Steady State	118	150
Maximum Junction-to-Lead <sup>C</sup>	$R_{\theta JL}$	54	68	$^\circ C/W$

Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	20			V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}$ $T_J = 55^\circ\text{C}$			1 5	$\mu\text{A}$
$I_{GSS}$	Gate-Body leakage current	$V_{DS} = 0\text{V}, V_{GS} = \pm 10\text{V}$			$\pm 10$	$\mu\text{A}$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	0.5	0.7	1	V
$I_{D(ON)}$	On state drain current	$V_{GS} = 4.5\text{V}, V_{DS} = 5\text{V}$	25			A
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS} = 4.5\text{V}, I_D = 5.0\text{A}$ $T_J = 125^\circ\text{C}$	18 26	23 33	28 40	$\text{m}\Omega$
		$V_{GS} = 4.0\text{V}, I_D = 4.5\text{A}$	19	24	30	$\text{m}\Omega$
		$V_{GS} = 3.1\text{V}, I_D = 4.5\text{A}$	20	27	34	$\text{m}\Omega$
		$V_{GS} = 2.5\text{V}, I_D = 4.0\text{A}$	21	30	39	$\text{m}\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS} = 5\text{V}, I_D = 5.0\text{A}$		18		S
$V_{SD}$	Diode Forward Voltage	$I_S = 1\text{A}, V_{GS} = 0\text{V}$		0.65	1	V
$I_S$	Maximum Body-Diode Continuous Current				1.3	A
<b>DYNAMIC PARAMETERS</b>						
$C_{iss}$	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=10\text{V}, f=1\text{MHz}$		180	225	pF
$C_{oss}$	Output Capacitance			95		pF
$C_{riss}$	Reverse Transfer Capacitance			18		pF
$R_g$	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$		2.7	4	k $\Omega$
<b>SWITCHING PARAMETERS</b>						
$Q_g$	Total Gate Charge	$V_{GS} = 4.5\text{V}, V_{DS} = 10\text{V}, I_D = 5\text{A}$		5.6	7.5	nC
$Q_{gs}$	Gate Source Charge			0.85		nC
$Q_{gd}$	Gate Drain Charge			1.7		nC
$t_{D(on)}$	Turn-On DelayTime	$V_{GS}=10\text{V}, V_{DS}=10\text{V}, R_L=2.0\Omega,$ $R_{GEN}=3\Omega$		172		ns
$t_r$	Turn-On Rise Time			368		ns
$t_{D(off)}$	Turn-Off DelayTime			2.94		$\mu\text{s}$
$t_f$	Turn-Off Fall Time			2.5		$\mu\text{s}$
$t_{rr}$	Body Diode Reverse Recovery Time	$I_F=5\text{A}, di/dt=100\text{A}/\mu\text{s}$		32	43	ns
$Q_{rr}$	Body Diode Reverse Recovery Charge	$I_F=5\text{A}, di/dt=100\text{A}/\mu\text{s}$		3.2		nC

A: The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^\circ\text{C}$ . in any given application depends on the user's specific board design. The current rating is based on the  $t \leq 10\text{s}$  thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using  $< 300\mu\text{s}$  pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The SOA curve provides a single pulse rating.

Rev2: Nov. 2010

THIS PRODUCT HAS BEEN DESIGNED AND QUALIFIED FOR THE CONSUMER MARKET. APPLICATIONS OR USES AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO IMPROVE PRODUCT DESIGN, FUNCTIONS AND RELIABILITY WITHOUT NOTICE.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

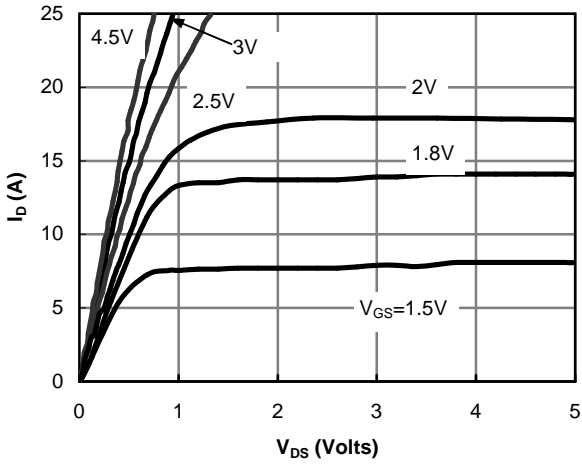


Figure 1: On-Region Characteristics

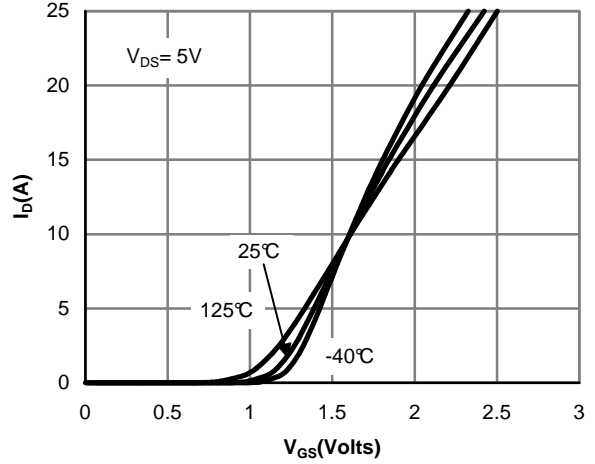


Figure 2: Transfer Characteristics

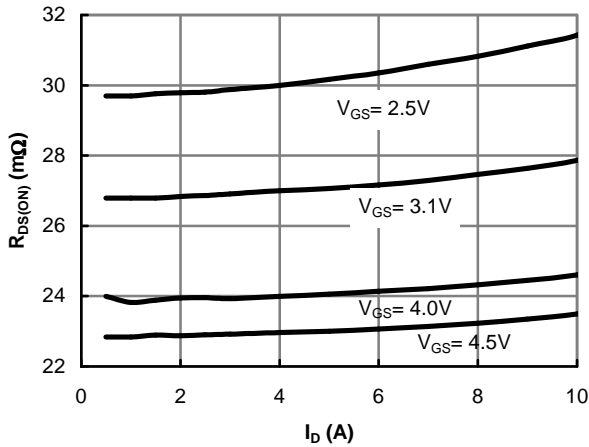


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

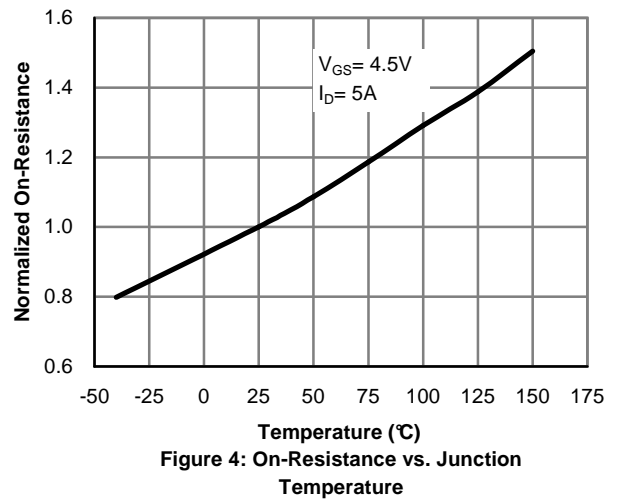


Figure 4: On-Resistance vs. Junction Temperature

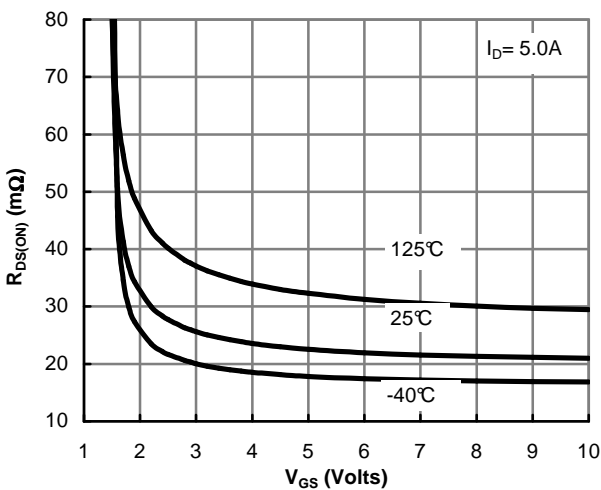


Figure 5: On-Resistance vs. Gate-Source Voltage

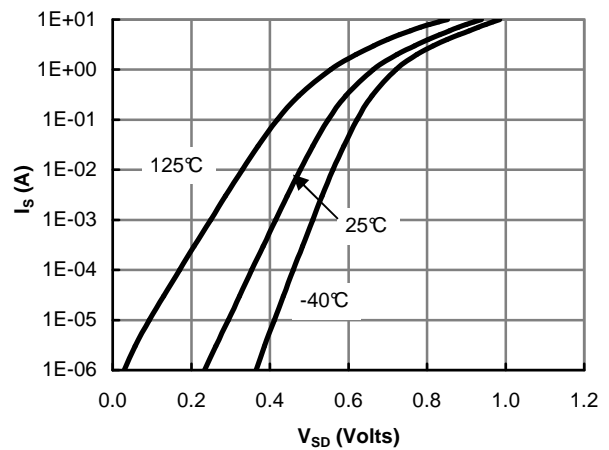


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

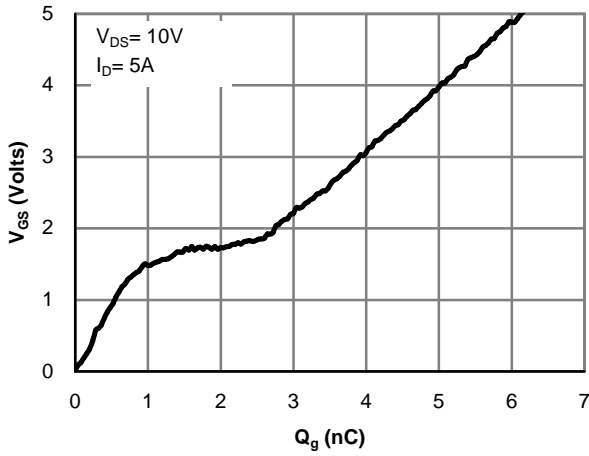


Figure 7: Gate-Charge Characteristics

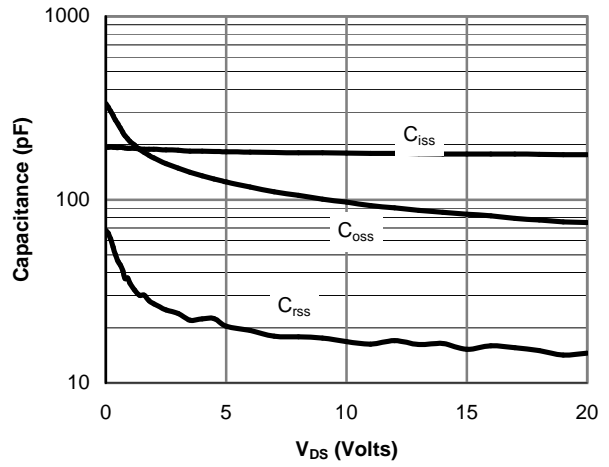


Figure 8: Capacitance Characteristics

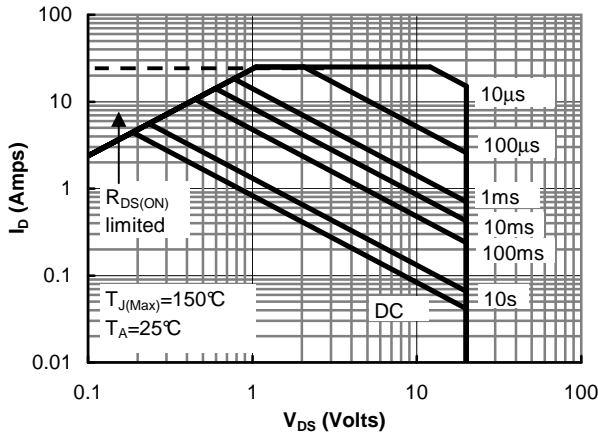


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

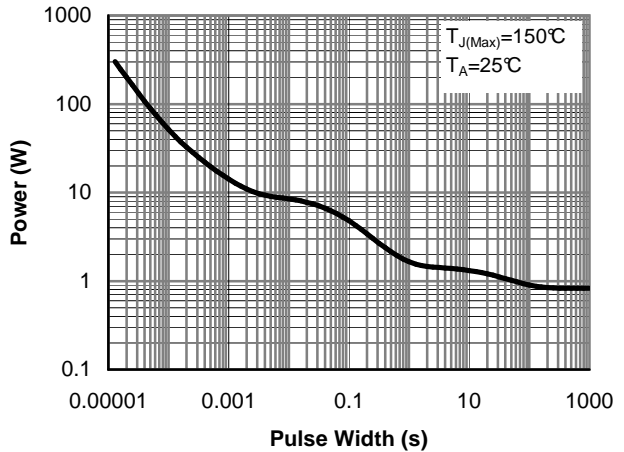


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

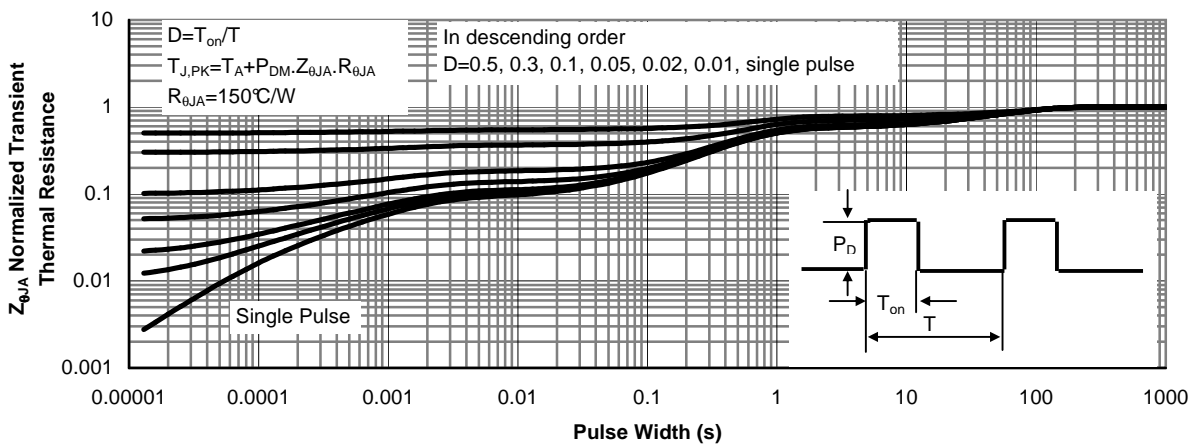
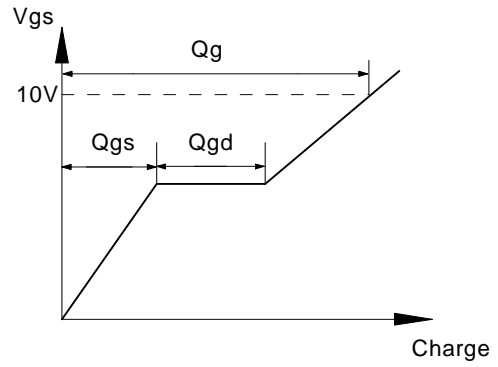
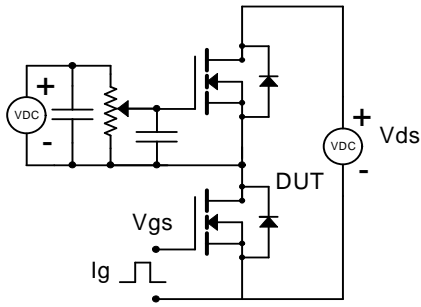
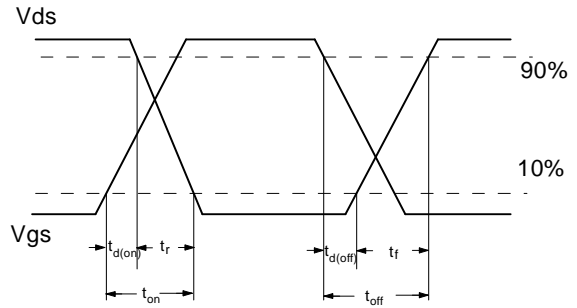
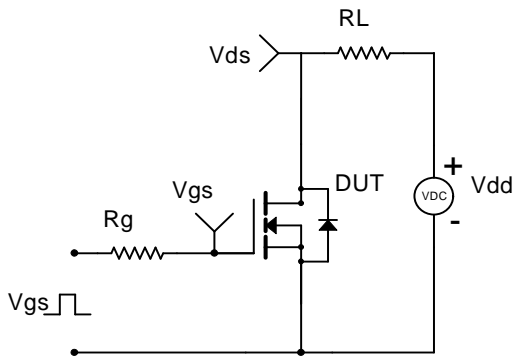


Figure 11: Normalized Maximum Transient Thermal Impedance (Note E)

Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

